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Manufacturer: National Instruments

Board Assembly Part Numbers (Refer to Procedure 1 for identification procedure):

Part Number and Revision	Description
199774C-03L or later	NI PCIe-8430, 2-PORT RS232
199774C-04L or later	NI PCIe-8431, 2-PORT RS485
199774C-01L or later	NI PCIe-8432, 2-PORT ISOLATED RS232
199774C-02L or later	NI PCIe-8433, 2-PORT ISOLATED RS485

Volatile Memory

Target Data	Туре	Size	Battery Backup	User ¹ Accessible	System Accessible	Sanitization Procedure
Glue Logic	FPGA	Intel EP1C3T	No	No	Yes	Cycle Power
UART	FPGA	Xilinx XC6SLX9	No	No	No	Cycle Power

Non-Volatile Memory (incl. Media Storage)

Target Data	Type	Size	Battery Backup	User Accessible	System Accessible	Sanitization Procedure
Device configuration	Flash	512 KB	No			
 Device information 				No	Yes	None
 FPGA bitstream 				No	Yes	None
FPGA bitstream	Flash	4 Mbit	No	No	No	None

¹ Refer to Terms and Definitions section for clarification of User and System Accessible

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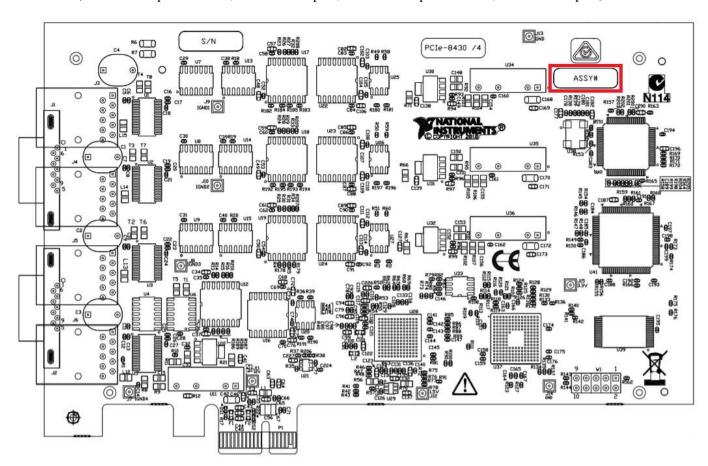
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Procedures

Procedure 1 – Board Assembly Part Number identification:

To determine the Board Assembly Part Number and Revision, refer to the "Assy#" label applied to the surface of your product as marked by red on the drawing below. The Assembly Part Number should be formatted as "P/N: ####a-xyL" where "a" is the letter revision of the Board Assembly (eg. A, B, C...X) and the "xy" is the type definition (01 = 8432 2-port isolated, 03 = 8430 2-port, 02 = 8433 2-port isolated, 04 = 8431 2-port).



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Terms and Definitions

Cycle Power:

The process of completely removing power from the device and its components and allowing for adequate discharge. This process includes a complete shutdown of the PC and/or chassis containing the device; a reboot is not sufficient for the completion of this process.

Volatile Memory:

Requires power to maintain the stored information. When power is removed from this memory, its contents are lost. This type of memory typically contains application specific data such as capture waveforms.

Non-Volatile Memory:

Power is not required to maintain the stored information. Device retains its contents when power is removed. This type of memory typically contains information necessary to boot, configure, or calibrate the product or may include device power up states.

User Accessible:

The component is read and/or write addressable such that a user can store arbitrary information to the component from the host using a publicly distributed NI tool, such as a Driver API, the System Configuration API, or MAX.

System Accessible:

The component is read and/or write addressable from the host without the need to physically alter the product.

Clearing:

Per NIST Special Publication 800-88 Revision 1, "clearing" is a logical technique to sanitize data in all User Accessible storage locations for protection against simple non-invasive data recovery techniques using the same interface available to the user; typically applied through the standard read and write commands to the storage device.

Sanitization:

Per NIST Special Publication 800-88 Revision 1, "sanitization" is a process to render access to "Target Data" on the media infeasible for a given level of effort. In this document, clearing is the degree of sanitization described.